Keysight Technologies P-Series Power Meter/Sensor LTE Measurement

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Technical Overview with Self-Guided Demonstration Guide

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Accelerate your LTE Signal Burst Power Measurement with Keysight P-Series Power Meter/Sensor

Using the industry's latest development technology, the long term evolution (LTE) standard from the 3rd Generation Partnership Project (3GPP) is deployed all around the world. The complexity of the LTE system requires comprehensive signal and modulation analysis as well as RF power measurement. The Keysight Technologies, Inc. P-Series power meter/sensor makes it possible to measure the sub-frame signal of time-division-duplex (LTE-TDD) and average burst power signal of frequency-division-duplex (LTE-FDD) with built-in LTE predefined measurement setup and statistical complementary cumulative distribution function (CCDF) measurement.

This document explains how to generate LTE-TDD and LTE-FDD signals using Keysight N7624B/N7625A Signal Studio software along with Keysight ESG Vector Signal Generator. A step-by-step guide demonstrates time-gated/ average burst signal measurement as well as CCDF measurement for LTE-TDD and LTE-FDD signals using Keysight P-Series power meter and sensor.

Introduction

The combination of N1911A/12A P-Series power meters and N1921A/22A wideband power sensors can quickly and accurately measure peak, average, peak-to-average ratio power measurement, rise/fall time, pulse width, and complementary cumulative distribution function (CCDF) statistical data for wideband signals.

The 30 MHz video bandwidth and 100×10^6 samples per second sampling rate of the P-Series power meter make it possible to capture signals with high crest factor and fast transition times which is the characteristic of LTE signals. The diode-based P-Series power sensor offers a higher frequency range of up to 40 GHz and wider dynamic range of up to 55 dB for better sensitivity to enable reliable measurements of peak and average burst power.

Further simplifying measurement set up, the one-button predefined preset LTE setup of the P-Series power meter reduces the setup time required to capture the signal effectively. By following a few easy steps, you can use the P-Series power meter/sensor to obtain power versus time (PvT) measurement and statistical CCDF for LTE-TDD and LTE-FDD signals.



Power versus Time (PvT)

Power level transmission is an important LTE conformance specification. It is defined as the time-average power over the useful period of a downlink or uplink subframe burst. Peak-to-average power can also be obtained during this period. To make accurate and stable measurements, it is important that the power meter is able to capture the desired complete subframe consistently within the fixed timeframe. This can be achieved by applying a proper time-triggering mechanisms, such as trigger level, holdoff, and delay, which are available in the P-Series power meters.

The trigger level of a P-Series power meter is typically set at auto-level. Trigger holdoff ensures that the acquisition will not occur until the holdoff time has passed and a valid trigger is found. This is very useful for burst signals that have amplitude variations, because these variations can cause false triggering. Trigger delay allows measurement of different signals. By just changing the delay setting of the power meter, you can make a power measurement of the next subframe.

Furthermore, the P-Series power meter is optimized to operate in the trace display when measuring a burst signal. Downlink or uplink subframe burst signals can be captured via time-gated methodology by applying the markers (1 & 2) of the trace.

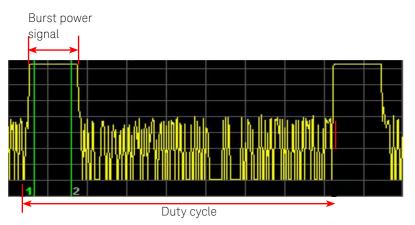


Figure 1. Burst power signal structure without constant duty cycle. In the P-Series power meter, green lines (Marker 1 and Marker 2) are indicate the start and end burst sub-frame signal power measurement.

Complementary Cumulative Distribution Function (CCDF)

The complementary cumulative distribution function (CCDF) is a plot of probability versus peak-to-average (PAR), which characterizes the statistical power of a signal. CCDF is one of the important measurements in designing LTE power amplifiers that must be capable of handling high PAR signal exhibits while constantly maintaining good adjacent-channel leakage performance. The CCDF plot is primarily used in the wireless communication market for evaluating multicarrier power amplifier performance. It measures the percentage of time when the PAR is at or exceeds a specific power level.

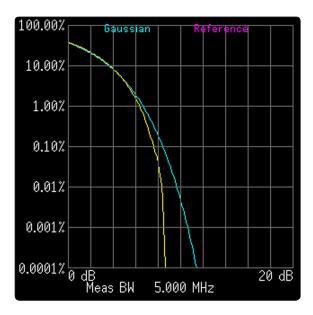


Figure 2. CCDF plot shows the Y-axis represents the percentage of time the signal power is at or exceeds the power specified by the X-axis

LTE Overview

LTE is the next major step in mobile radio communications, and will be introduced in 3GPP Release 8. The LTE specification provides a framework for increasing capacity, improving spectrum efficiency, improving coverage, and reducing latency compared with current high speed packet access (HSPA) implementations. In addition, transmission with multiple input and multiple output (MIMO) antennas will be supported for greater throughput, as well as enhanced capacity or range.

Key Attributes for LTE

- Downlink capacity Peak data rates up to 172.8 Mbps with 20 MHz bandwidth and 2x2 SU-MIMO
- Uplink capacity Peak data rates up to 86.4 Mbps with 20 MHz bandwidth and 64QAM
- Spectrum flexibility Scalable bandwidth up to 20 MHz
- Spectral efficiency Increased spectral efficiency over Release 6 HSPA by a factor of two to four
- Latency Sub-5 ms latency for small internet protocol (IP) packets
- Mobility Optimized for low mobile speed from 0 to 15 km/h; higher mobile speeds up to 120 km/h supported with high performance
- Support for packet-switched domains only.

Multiple Access Technology

Downlink and uplink transmission in LTE are based on the use of multiple access technologies, specifically, orthogonal frequency division multiple access (OFDMA) for downlink and single-carrier frequency division multiple access (SC-FDMA) for the uplink.

This LTE overview information provides a quick review of some of the physical-layer characteristic of an LTE signal. Please refer to the Keysight 3GPP Long Term Evolution application note, literature number 5989-8139EN, for in-depth LTE technical information.

Transmission Bandwidth

In order to address the international wireless market and regional spectrum regulations, LTE allows selection of varying channel bandwidths, from 1.4 to 20 MHz, with sub-carrier spacing of 15 kHz. In the case of multimedia broadcast multicast service (MBMS), a sub-carrier spacing of 7.5 kHz is also possible. Sub-carrier spacing is constant regardless of channel bandwidth. To allow for operation with differently sized spectrum allocations, the transmission bandwidth is instead altered by varying the number of OFDM sub-carriers as shown in Table 1.

Table 1: Number of sub-carriers for the different downlink and uplink transmissionbandwidths

Transmission bandwidth for LTE FDD (MHz)	1.4	3	5	10	15	20
Number of sub-carriers	72	180	300	600	900	1200

LTE Overview (continued)

Frame Structure

There are two radio frame structures for LTE: frame structure type 1 (FS1) for full duplex and half duplex FDD, and frame structure type 2 (FS2) for TDD. The frame structure for full duplex FDD is shown in Figure 3.

FS1 is optimized to co-exist with 3.84 Mbps UMTS system. This structure consists of ten 1 ms sub-frames, each composed of two 0.5 ms slots, for total duration of 10 ms. The FSQ is the same in the uplink and downlink in terms of frame, sub-frame, and slot duration, although the allocation of the physical signals and channels is quite different. Uplink and downlink transmission are separated in the frequency domain.

	One radio frame, $T_f = 307200 T_s = 10 ms$					
One slot, T _{slpt} = 15360 T _s = 0.5 ms						
*						
One subframe						
	-	1				

Figure 3. LTE frame structure type 1 (TS 36.211 V8.30)

The structure of FS2 is much more flexible than the structure of FS1. An example of an FS2 structure is shown in Figure 4. This example shows 5 ms switch-point periodicity and it consists of two 5 ms half-frames for a total duration of 10 ms. Sub-frames consist of either an uplink or downlink transmission or a special sub-frame containing the downlink and uplink pilot timeslots (DwPTS and UpPTS) separated by a transmission gap guard period (GP). The allocation of the sub-frames for the uplink, downlink, and special sub-frames is determined by one of seven different configurations. Sub-frames 0 and 5 are always downlink transmissions, and sub-frame 1 is always a special sub-frame, but the composition of the other sub-frames vary depending on the frame configuration.

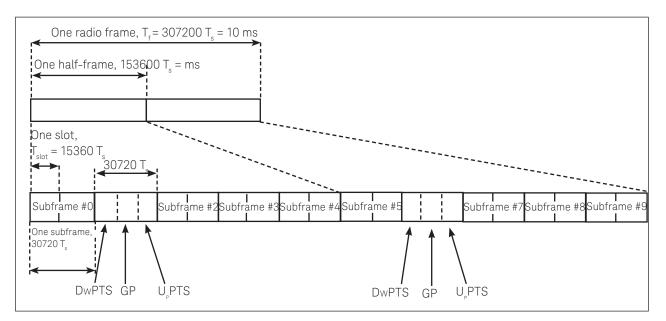


Figure 4. LTE frame structure Type 2 (5 ms switch-point periodicity) (TS 36.211 V8.20)

Demonstration Preparation

These demonstrations focuses on LTE measurements over a LAN connection.

The following instruments and software are used in this demo guide:

- E4438C ESG vector signal generator¹
- N1911A/N1912A P-Series power meter
- N1921A/1922A P-Series wideband power sensor
- N7625A (for LTE-TDD) and N7624B (for LTE-FDD) Signal Studio software2

Keysight Signal Studio is a Windowsbased utility software that simplifies creation of standard or customized LTE waveform. With the Signal Studio software, the desired LTE waveform profile can be configured and downloaded into a signal generator, and the signal generator will then generate the waveform for testing.

To download and update instrument firmware and software, visit:

- www.keysight.com/find/wideband
- www.keysight.com/find/esg
- www.keysight.com/find/mxg
- www.keysight.com/find/ signalstudio

Product type	Required option
ESG Vector Signal Genera- tor	E4438C firmware revision C.04.98 or later Frequency range option: 503 or 506 Baseband generator option: 601 or 602
P-Series Power Meter	N1911A or N1912A firmware revision A.05.03 or later
P-Series Wideband Power Sensor	N1921A or N1922A
Signal Studio software	N7625A version 1.1.2.0 or later (for LTE-TDD) N7624B version 7.5.0.1 or later (for LTE-FDD)
Keysight IO Libraries Suite	IO Libraries Suite version 15.1 or later
Controller PC for Signal Studio	Install N7625A Signal Studio software for LTE-TDD or N7624B for LTE-FDD. Refer to the online documentation for installation and setup.

Connecting the PC, ESG, and P-Series instructions

- 1. Connect the PC to the E4438C ESG signal generator via a LAN cable.
- 2. Launch the Keysight Connection Expert application (Keysight IO Libraries Suite) and verify the connection of the ESG signal generator.
- 3. Connect the P-Series power meter and sensor as shown in Figure 5.
- 4. Connect a BNC cable from the ESG signal generator's rear-panel Event 1 to the rear panel Trig In of the P-Series power meter.

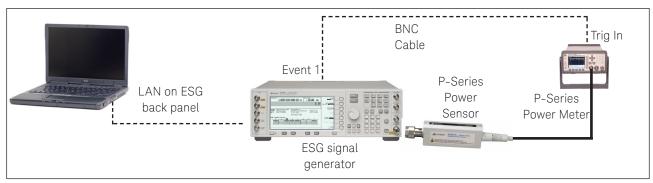


Figure 5. P-Series power meter and ESG signal generator setup diagram

- 1. Alternatively, you can use the N5182A MXG vector signal generator, firmware revision A.01.45 or later, frequency range option 503 or 506, and baseband generator option: 651 or 652.
- 2. N7625A is the LTE-TDD signal measurement PC platform software. For LTE-FDD signal measurement, N7624B can be used.

Establishing a communication link between EGS Signal Generator, Keysight IO Libraries Suite, and N7624B/N7625A Signal Studio software

Keystrokes surrounded by [] represent front-panel keys of the instruments, while keystrokes surrounded by {} represent softkeys of the instrument and software.

Instructions On the ESG:	Keystrokes
1. Set the instrument to its default settings.	Press [Preset].
2. Check the IP address.	 Press [Utility] {GPIB/RS-232/LAN} {LAN Setup} If connecting to network, press {LAN Config} {DHCP} {Proceed With Reconfiguration} {Confirm Change (Instrument Will Reboot)} If direct connection from PC to ESG, press {LAN Config} {Manual}, enter the appropriate IP Address, Subnet Mask and Default Gateway. Press {Proceed With Reconfiguration} {Confirm Change (Instrument Will Reboot)}.
On Keysight IO Libraries Suit Software :	
3. Start the Keysight IO Libraries Suite.	Start > All Programs > Keysight IO Libraries Suit > Keysight Connection Expert.
4. Establish the LAN connection of PC to ESG.	Right-click on LAN (TCPIO) and select Add Instrument. Click on Auto Find. Select the ESG LAN connection and click OK.
On N7624B/N7625A Signal Studio softw	vare :
5. Start the Signal Studio for LTE-TDD or LTE-FDD	Start > All Program > Keysight Signal Studio > 3GPP LTE TDD > 3GPP LTE TDD or 3GPP LTE FDD.
6. Configure the ESG as hardware connected via LAN TCP/IP.	From the {System} pull-down menu at the top of the Signal Studio program win- dow, select {Change Hardware Connec- tions} , {Next} , select {LAN} and enter the hostname or IP address of the ESG in the address is. Click {Test I/O Connection} {Next} .
7. The software should return a "suc- cess" connection status.	 If connection is successful, click {Finish}. If connection is not successful, verify the instrument connection and the IP address or TCP/IP link.

Part 1: LTE-TDD Sub-Frame Burst Power Measurement

Downloading LTE-TDD mode profile into ESG Signal Generator

Profile setting	Instructions	Keystrokes		
Most parameters are in their default	On N7625A Signal Studio software:			
settings when Signal Studio is launched. Values in bold indicate modified parameters.	 Set the basic parameters of the Signal: 2 GHz frequency 	In the view, select Instrument under Hardware : Set Frequency to 2 GHz		
Generate a downlink sub-frame signal of LTE-TDD using N7625A Signal Studio software along with ESG vector	 – 0 dBm Amplitude – RF Output turned ON. 	Set Amplitude = 0 dBm RF Output = On		
signal generator.	2. Set the LTE signal for 10 MHz LTE profile and 16 QAM	In the tree view, select Carrier 1 under Waveform Setup :		
You should see the burst power measurement as shown in Figure 6. If you do not, make sure you	modulation format.	Under Channel Configuration, from drop down list, select Full filled 16QAM 10 MH (50 RB).		
have downloaded the Signal Studio waveform to the ESG and that the ESG's RF is turned ON [RF on/off].	3. Turn on downlink signal.	In the tree view, select Downlink under Carrier 1 Waveform Setup: Under Cell Parameters, set State to On .		
	4. Turn off uplink signal.	In the tree view, select Uplink under Carrier 1 Waveform Setup: Under Cell Parameters, set State to Off .		
	5. Download the signal to the ESG .	Press Generate and Download button on the top tool bar; if you encounter any errors, please refer to the online help of Signal Studio software.		

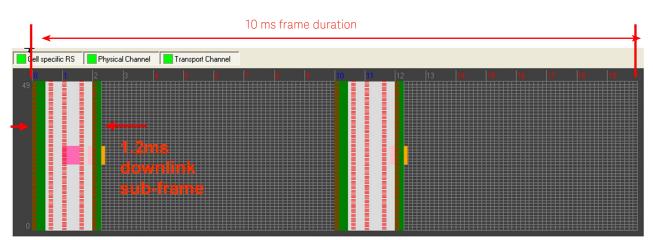


Figure 6. Sub-frame duration 1.2 ms of downlink signal captured with N7625B Signal Studio software

Measuring Downlink Sub-Frame Burst Power of LTE-TDD

Set up the P-Series power meter/ sensor to measure the downlink sub-frame signal of LTE-TDD.

Instructions On the P-Series power meter :	Keystrokes
1. Select the LTE preset.	Press [Preset], press [] or [] to choose {LTE}, [Select] and {Confirm}.
2. Set the frequency.	Press [Channel], press [] or [] to choose {Frequency} and change {Frequency} = 2 GHz.
 Set the video averaging to smooth the displayed trace. 	Press [Channel], press [], [], [], [] or [] to choose {Video Avg} = 8.
4. Set the trigger source to external allow power meter can be triggered via the Ext Trig input by ESG's Event 1.	Press [Trig/Acq], {Settings}, {Source}, {Ext}.
5. Expand the window. Change the scale of trace measure- ment.	Press [, {Trace Control} to Trace Control menu. Press [], [], [], [] or [] to choose and set the X & Y settings: {X Start = -500 us} {X Scale = 1.1 ms} {Y Scale = 20 dBm} {Y Scale = 10 dB}
 Move the markers 1 & 2 to capture 10 ms gated burst p measurement. (See Figure 7) 	Press {Gate Control } return to Gate Control menu. Press {Marker 1 2} . Press [] and [] to allocate the marker 1 and marker 2.
 Move the markers 1 & 2 to ca 1.2 ms downlink burst sub-frame signal. (See Figure 8) 	Apture Press {Marker 1 2} . Press [] and [] to allocate the marker 1 and marker 2.

Measuring Downlink Sub-Frame Burst Power of LTE-TDD (continued)

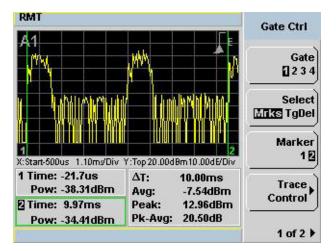


Figure 7. LTE waveform duration at 10 ms in TDD mode. In the P-Series power meter, green lines (Marker 1 and Marker 2) indicate the start and end burst waveform of the signal.

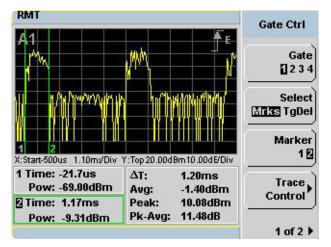


Figure 8. Downlink average burst power signal measures -1.40 dBm at 1.2 ms sub-frame duration. In the P-Series power meter, green lines (Marker 1 and Marker 2) indicate the start and end burst sub-frame signal of the downlink.

Measuring Uplink Sub-Frame Burst Power of LTE-TDD

Generate an uplink sub-frame signal using N7625A Signal Studio software along with ESG vector signal generator.

Instructions On the Signal Studio signal:	Software Requirements
1. Turn off downlink signal.	In the tree view, select Downlink under Carrier 1 Waveform Setup . Under Cell Parameters, set State to Off .
2. Turn on uplink signal.	In the tree view, select Uplink under Car- rier 1 Waveform Setup . Under Cell Parameters, set State to On .
3. Download the signal to the ESG .	Press Generate and Download button on the top tool bar; if you encounter any errors; please refer to the online help for Signal Studio software.

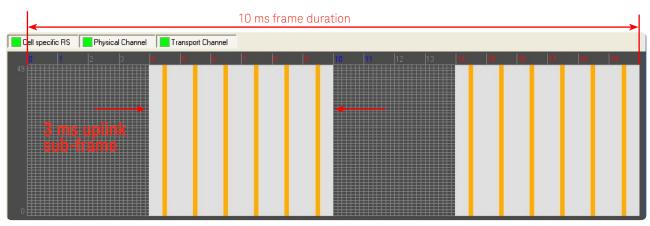


Figure 9. Sub-frame duration 3 ms of uplink signal captured with Signal Studio

Set up the P-Series power meter/ sensor to measure the uplink subframe signal of LTE-TDD.

Instructions	Keystrokes
On the P-Series power meter:	
 Move the markers 1 & 2 to capture 3 ms uplink burst sub-frame signal. (See Figure 10). 	From Gate Control menu, press {Marker 1 2} . Press [] and [] to allocate the marker 1 and marker 2.

RMT							Gate Ctrl
M M	rndaann	~mprd		n/n	shup.		Gate [] 2 3 4
						M	Select Mirks TgDel
1 X: Start-50Dus	s 1.10ms/	Div Y	2 :Top 20.00	dBm 1	0.00dE/	Div	Marker [] 2
	0.13dBn	n	ΔT: Avg:	0.	01ms 00dBr		Trace
2 Time: 6 Pow: -3	38.75dB	n	Peak: Pk-Avg		95dBr 95dB	n	1 of 2)

Figure 10. Uplink average burst power signal measures 0 dBm at 3 ms sub-frame duration. In the P-Series power meter, green lines (Marker 1 and Marker 2) indicate the start and end burst sub-frame signals of uplink.

Part 2 : LTE-TDD CCDF Power Statisctical Measurement

CCDF is generally measured with data that is as random as possible to match the Gaussian curve. The CCDF waveform provides statistics for the input signal, analyzed over 1 seconds asynchronously to any features of the signal. 100 MHz samples are histogrammed in real time so we can have the statistics on 100 million samples.

The P-Series power meter provides waveform CCDF measurement in graphical and table formats (See Figure 12 and Figure 13). In Figure 11, the Signal Studio under waveform setup shows that the CCDF plot and the table to the left of the CCDF plot display the calculated peak-to-average values. The blue line represents the Gaussian noise and the yellow line represents the input signal. Prior to measurement, a reference trace is set and compared with the Gaussian noise trace.

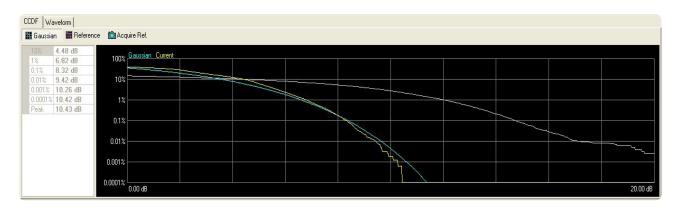


Figure 11. Waveform CCDF calculates the CCDF and peak-to-average ratio using the entire LTE-TDD waveform (with downlink signal off and uplink signal on)

LTE-TDD CCDF Power Statisctical Measurement (continued)

(See Figure 13).

Set up the P-Series power meter/ sensor to measure the LTE-TDD statistical CCDF (downlink signal off and uplink signal on only).

Instructions	Keystrokes
On the P-Series power meter:	
 Set the acquisition to "Free Run". 	Press [Trig/Acq], {Acqn A}, {Free Run}.
2. Set the CCDF in trace format.	Press [Disp], {Disp Type}, {1 of 2}, {CCDF Trace}.
3. Set the trace scale to 20 dB.	Press {Trace Control}, {Scale/Div 2dB}.
4. Set the Gaussian noise trace.	Press {Trace Display}, {Gaussian} . Press [Prev/Esc] return to Trace Ctrl menu.
5. Set marker 1 to 10% and marker 2 to 1% of time. (See Figure 12).	Press {Marker Control}, press {Marker 1 2}. Press [] and [] to allocate the marker 1 and marker 2.
6. Set the CCDF in table format and expand the display.	[Disp], {Disp Type}. {1 of 2}, {CCDF Table}, [+]].

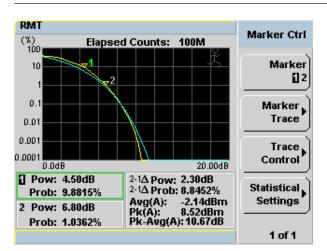


Figure 12. CCDF graphical format. The yellow line is the input signal. The blue reference line is the band-limited Gaussian noise curve. Marker 1 and Marker 2 indicate 10% and 1% of time at a specified power measurement.

RMT				CCDF
A			,	Table
7	10%	4.46dB	£	Statistical
	1%	6.83dB		Settings
	0.1%	8.35dB	1	
	0.01%	9.44dB	1	
	0.001%	10.21dB		
	0.0001%	10.56dB		
	% 0.00000	: 10.643 dB		
	dB 0.000	: 31.333 %		
	Sample Coun Elapsed Coun			
				1 of 1

Figure 13. CCDF table format

Part 3 : LTE-FDD Average Burst Power Measurement

Downloading LTE-FDD mode profile into ESG Signal Generator

Note: To establish a communication link between ESG signal generator, Keysight IO libraries Suite and N7624B Signal Studio software for LTE-FDD, please refer to page 8 for detailed procedures.

Profile setting

Generate a downlink LTE signal using 3GPP LTE-FDD Signal Studio along with the Keysight ESG vector signal generator.

Instructions On N7624B Signal Studio software:	Keystrokes
 Set the basic parameters of the Signal: 2 GHz frequency 0 dBm Amplitude RF Output turned ON. 	In the view, select Instrument under Hardware : Set Frequency to 2 GHz Set Amplitude = 0 dBm RF Output = On
2. Download the signal to the ESG .	Press Generate and Download button on the top tool bar; if you encounter any errors, please refer to the online help of Signal Studio software.

Measuring Average Burst Power of LTE FDD

Set up the P-Series power meter/ sensor to measure average burst power of LTE-FDD.

Instructions	Keystrokes
On the P-Series power meter:	
1. Preset the power meter.	Press [Preset], press [] or [] to choose { Default }, [Select] and { Confirm }.
2. Set the frequency.	Press [Channel], press [] or [] to choose {Frequency} and change {Frequency} = 2 GHz. (See Figure 14 for measurement result).

RMT A 2.0GHz ♀	Disp Form
	Disp Type
-0.09 _{dBm}	Trace\Table Feed Ch.A
	Resolution 1284
🔥 No Sensor ChB	Units •
	1 of 2 ▶

Figure 14. Average burst power of LTE-FDD measurement at 0 dBm

Conclusion

Accurately measuring the sub-frame burst power of LTE-TDD and average burst power of LTE-FDD are very important for LTE conformance testing. The P-Series power meter/sensor are capable to measure downlink/uplink sub-frame signal of LTE-TDD and average burst power of LTE-FDD accurately. This document outlines the following key features of the P-Series power meter/sensor for LTE power measurement conformance testing:

- One-button LTE predefined preset to simplify the measurement setup effectively
- Auto-trigger with hold off
- 30 MHZ video bandwidth capable to capture 20 MHz video bandwidth of LTE signal
- 100 Msa/s
- Measurement speed match burst rate: useful for high speed dynamic transmitter power calibration
- Power statistical CCDF graphical and tabular format

Ordering Information

For further information, refer to P-Series Power Meters and Power Sensors Configuration Guide, Literature No : 5989-1252EN

Product Type	Model Number
P-Series power meter	N1911A or N1912A
P-Series wideband power sensor	N9121A or N1922A

Related Keysight Literature

Publication title	Pub number
P-Series Power Meters and P-Series Wideband Power Sensors Technical Overview	5989-1049EN
P-Series Power Meters and Power Sensors Configuration Guide	5989-1252EN
N1911A/N1912A P-Series Power Meters and N1921A/N1922A Wideband Power Sensors Data Sheet	5989-2471EN

Reference

Publication title	Pub number
Keysight 3GPP Long Term Evolution Application Note	5989-8139EN
Keysight Technologies Solutions for 3GPP LTE Technical Overview	5989-6331EN
Keysight Move Forward to What's Possible in LTE	5989-7871EN

Related Web Resources

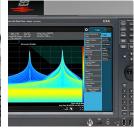
For the latest and most complete applications and information, please refer to the following URL: www.keysight.com/find/wideband_powermeters

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